

Notice of References Cited

Application/Control No.

10/566,655

Applicant(s)/Patent Under
Reexamination
TODE ET AL.

Examiner

Karie O'Neill

Art Unit

1795

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0012830	01-2002	Uemura et al.	429/60
*	C	US-2003/0180620	09-2003	Nakane et al.	429/231.95
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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